



Welcome to [E-XFL.COM](#)

What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	e200z0h
Core Size	32-Bit Single-Core
Speed	64MHz
Connectivity	CANbus, I ² C, LINbus, SCI, SPI
Peripherals	DMA, POR, PWM, WDT
Number of I/O	123
Program Memory Size	512KB (512K x 8)
Program Memory Type	FLASH
EEPROM Size	64K x 8
RAM Size	32K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 36x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP
Supplier Device Package	144-LQFP (20x20)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/spc5604bf2mlq6

Package pinouts and signal descriptions

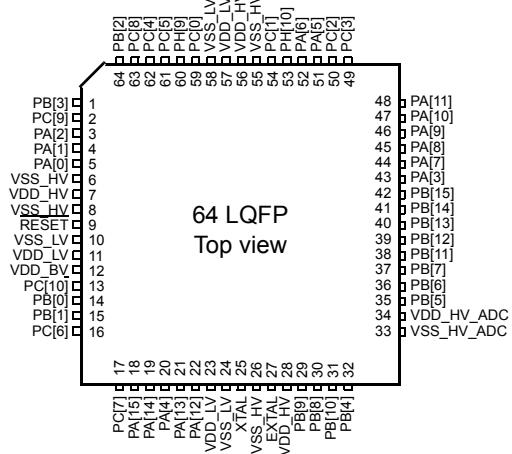


Figure 2. MPC560xB LQFP 64-pin configuration

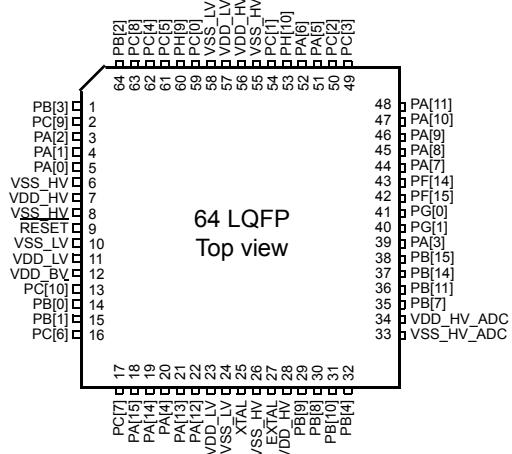


Figure 3. MPC560xC LQFP 64-pin configuration

3.5 System pins

The system pins are listed in [Table 5](#).

Table 5. System pin descriptions

System pin	Function	I/O direction	Pad type	RESET configuration	Pin number			
					64 LQFP ¹	100 LQFP	144 LQFP	208 MAPBGA ²
RESET	Bidirectional reset with Schmitt-Trigger characteristics and noise filter.	I/O	M	Input, weak pull-up only after PHASE2	9	17	21	J1
EXTAL	Analog output of the oscillator amplifier circuit, when the oscillator is not in bypass mode. Analog input for the clock generator when the oscillator is in bypass mode. ³	I/O	X	Tristate	27	36	50	N8
XTAL	Analog input of the oscillator amplifier circuit. Needs to be grounded if oscillator is used in bypass mode. ³	I	X	Tristate	25	34	48	P8

¹ Pin numbers apply to both the MPC560xB and MPC560xC packages.

² 208 MAPBGA available only as development package for Nexus2+

³ See the relevant section of the datasheet

3.6 Functional ports

The functional port pins are listed in [Table 6](#).

Table 6. Functional port pin descriptions

Port pin	PCR	Alternate function ¹	Function	Peripheral	I/O direction ²	Pad type	RESET configuration	Pin number				
								MPC560xB 64 LQFP	MPC560xC 64 LQFP	100 LQFP	144 LQFP	208 MAPBGA ³
PA[0]	PCR[0]	AF0 AF1 AF2 AF3 —	GPIO[0] E0UC[0] CLKOUT — WKPU[19] ⁴	SIUL eMIOS_0 CGL — WKPU	I/O I/O O — I	M	Tristate	5	5	12	16	G4
PA[1]	PCR[1]	AF0 AF1 AF2 AF3 —	GPIO[1] E0UC[1] — — NMI ⁵ WKPU[2] ⁴	SIUL eMIOS_0 — — WKPU WKPU	I/O I/O — — I I	S	Tristate	4	4	7	11	F3

Table 6. Functional port pin descriptions (continued)

Port pin	PCR	Alternate function ¹	Function	Peripheral	I/O direction ²	Pad type	RESET configuration	Pin number				
								MPC560xB 64 LQFP	MPC560xC 64 LQFP	100 LQFP	144 LQFP	208 MAPBGA ³
PA[2]	PCR[2]	AF0 AF1 AF2 AF3 —	GPIO[2] E0UC[2] — — WKPU[3] ⁴	SIUL eMIOS_0 — — WKPU	I/O I/O — — I	S	Tristate	3	3	5	9	F2
PA[3]	PCR[3]	AF0 AF1 AF2 AF3 —	GPIO[3] E0UC[3] — — EIRQ[0]	SIUL eMIOS_0 — — SIUL	I/O I/O — — I	S	Tristate	43	39	68	90	K15
PA[4]	PCR[4]	AF0 AF1 AF2 AF3 —	GPIO[4] E0UC[4] — — WKPU[9] ⁴	SIUL eMIOS_0 — — WKPU	I/O I/O — — I	S	Tristate	20	20	29	43	N6
PA[5]	PCR[5]	AF0 AF1 AF2 AF3 —	GPIO[5] E0UC[5] — —	SIUL eMIOS_0 — —	I/O I/O — —	M	Tristate	51	51	79	118	C11
PA[6]	PCR[6]	AF0 AF1 AF2 AF3 —	GPIO[6] E0UC[6] — — EIRQ[1]	SIUL eMIOS_0 — — SIUL	I/O I/O — — I	S	Tristate	52	52	80	119	D11
PA[7]	PCR[7]	AF0 AF1 AF2 AF3 —	GPIO[7] E0UC[7] LIN3TX — EIRQ[2]	SIUL eMIOS_0 LINFlex_3 — SIUL	I/O I/O O — I	S	Tristate	44	44	71	104	D16
PA[8]	PCR[8]	AF0 AF1 AF2 AF3 — N/A ⁶ —	GPIO[8] E0UC[8] — — EIRQ[3] ABS[0] LIN3RX	SIUL eMIOS_0 — — SIUL BAM LINFlex_3	I/O I/O — — I I I	S	Input, weak pull-up	45	45	72	105	C16
PA[9]	PCR[9]	AF0 AF1 AF2 AF3 N/A ⁶	GPIO[9] E0UC[9] — — FAB	SIUL eMIOS_0 — — BAM	I/O I/O — — I	S	Pull-down	46	46	73	106	C15

Table 6. Functional port pin descriptions (continued)

Port pin	PCR	Alternate function ¹	Function	Peripheral	I/O direction ²	Pad type	RESET configuration	Pin number				
								MPC560xB 64 LQFP	MPC560xC 64 LQFP	100 LQFP	144 LQFP	208 MAPBGA ³
PB[3]	PCR[19]	AF0 — AF1 — AF2 — AF3 — —	GPIO[19] — SCL — WKPU[11] ⁴ LIN0RX	SIUL — I2C_0 — WKPU LINFlex_0	I/O — I/O — — —	S — — — — —	Tristate	1	1	1	1	C3
PB[4]	PCR[20]	AF0 AF1 AF2 AF3 —	GPIO[20] — — — GPI[0]	SIUL — — — ADC	I — — — —	I — — — —	Tristate	32	32	50	72	T16
PB[5]	PCR[21]	AF0 AF1 AF2 AF3 —	GPIO[21] — — — GPI[1]	SIUL — — — ADC	I — — — —	I — — — —	Tristate	35	—	53	75	R16
PB[6]	PCR[22]	AF0 AF1 AF2 AF3 —	GPIO[22] — — — GPI[2]	SIUL — — — ADC	I — — — —	I — — — —	Tristate	36	—	54	76	P15
PB[7]	PCR[23]	AF0 AF1 AF2 AF3 —	GPIO[23] — — — GPI[3]	SIUL — — — ADC	I — — — —	I — — — —	Tristate	37	35	55	77	P16
PB[8]	PCR[24]	AF0 AF1 AF2 AF3 — —	GPIO[24] — — — ANS[0] OSC32K_XTAL ⁷	SIUL — — — ADC SXOSC	I — — — — I/O	I — — — — —	Tristate	30	30	39	53	R9
PB[9]	PCR[25]	AF0 AF1 AF2 AF3 — —	GPIO[25] — — — ANS[1] OSC32K_EXTAL ⁷	SIUL — — — ADC SXOSC	I — — — — I/O	I — — — — —	Tristate	29	29	38	52	T9

Package pinouts and signal descriptions

Table 14. Recommended operating conditions (5.0 V)

Symbol		Parameter	Conditions	Value		Unit
				Min	Max	
V _{SS}	SR	Digital ground on VSS_HV pins	—	0	0	V
V _{DD} ¹	SR	Voltage on VDD_HV pins with respect to ground (V _{SS})	—	4.5	5.5	V
			Voltage drop ²	3.0	5.5	
V _{SS_LV} ³	SR	Voltage on VSS_LV (low voltage digital supply) pins with respect to ground (V _{SS})	—	V _{SS} -0.1	V _{SS} +0.1	V
V _{DD_BV} ⁴	SR	Voltage on VDD_BV pin (regulator supply) with respect to ground (V _{SS})	—	4.5	5.5	V
			Voltage drop ²	3.0	5.5	
			Relative to V _{DD}	V _{DD} -0.1	V _{DD} +0.1	
V _{SS_ADC}	SR	Voltage on VSS_HV_ADC (ADC reference) pin with respect to ground (V _{SS})	—	V _{SS} -0.1	V _{SS} +0.1	V
V _{DD_ADC} ⁵	SR	Voltage on VDD_HV_ADC pin (ADC reference) with respect to ground (V _{SS})	—	4.5	5.5	V
			Voltage drop ²	3.0	5.5	
			Relative to V _{DD}	V _{DD} -0.1	V _{DD} +0.1	
V _{IN}	SR	Voltage on any GPIO pin with respect to ground (V _{SS})	—	V _{SS} -0.1	—	V
			Relative to V _{DD}	—	V _{DD} +0.1	
I _{INJPAD}	SR	Injected input current on any pin during overload condition	—	-5	5	mA
I _{INJSUM}	SR	Absolute sum of all injected input currents during overload condition	—	-50	50	
T _{V_{DD}}	SR	V _{DD} slope to ensure correct power up ⁶	—	—	0.25	V/μs
T _A C-Grade Part	SR	Ambient temperature under bias	f _{CPU} ≤ 64 MHz	-40	85	°C
T _J C-Grade Part	SR	Junction temperature under bias		-40	110	
T _A V-Grade Part	SR	Ambient temperature under bias		-40	105	
T _J V-Grade Part	SR	Junction temperature under bias		-40	130	
T _A M-Grade Part	SR	Ambient temperature under bias		-40	125	
T _J M-Grade Part	SR	Junction temperature under bias		-40	150	

¹ 100 nF capacitance needs to be provided between each V_{DD}/V_{SS} pair.

² Full device operation is guaranteed by design when the voltage drops below 4.5 V down to 3.0 V. However, certain analog electrical characteristics will not be guaranteed to stay within the stated limits.

³ 330 nF capacitance needs to be provided between each V_{DD_LV}/V_{SS_LV} supply pair.

⁴ 100 nF capacitance needs to be provided between V_{DD_BV} and the nearest V_{SS_LV} (higher value may be needed depending on external regulator characteristics).

⁵ 100 nF capacitance needs to be provided between V_{DD_ADC}/V_{SS_ADC} pair.

⁶ Guaranteed by device validation

NOTE

RAM data retention is guaranteed with V_{DD_LV} not below 1.08 V.

3.15.2 I/O input DC characteristics

Table 16 provides input DC electrical characteristics as described in Figure 7.

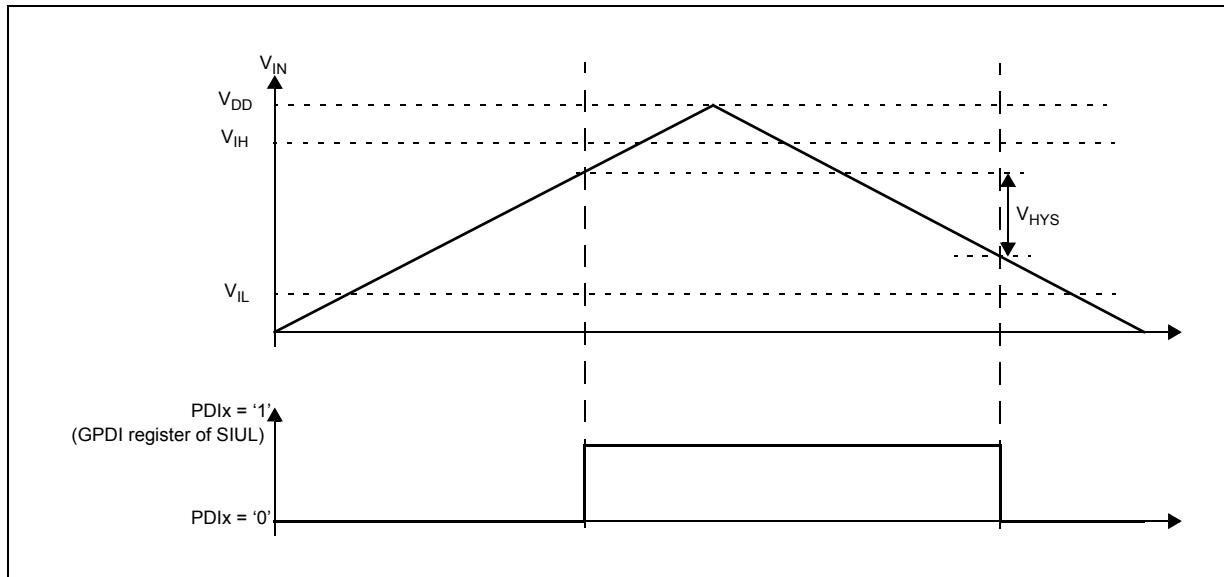


Figure 7. I/O input DC electrical characteristics definition

Table 16. I/O input DC electrical characteristics

Symbol	C	Parameter	Conditions ¹	Value			Unit
				Min	Typ	Max	
V _{IH}	SR	P	Input high level CMOS (Schmitt Trigger)	—	0.65V _{DD}	—	V _{DD} +0.4
V _{IL}	SR	P	Input low level CMOS (Schmitt Trigger)	—	-0.4	—	0.35V _{DD}
V _{HYS}	CC	C	Input hysteresis CMOS (Schmitt Trigger)	—	0.1V _{DD}	—	—
I _{LKG}	CC	D	Digital input leakage No injection on adjacent pin	T _A = -40 °C	—	2	200
				T _A = 25 °C	—	2	200
				T _A = 85 °C	—	5	300
				T _A = 105 °C	—	12	500
				T _A = 125 °C	—	70	1000
W _{FI} ²	SR	P	Wakeup input filtered pulse	—	—	—	40 ns
W _{NFI} ²	SR	P	Wakeup input not filtered pulse	—	1000	—	— ns

¹ V_{DD} = 3.3 V ± 10% / 5.0 V ± 10%, T_A = -40 to 125 °C, unless otherwise specified

² In the range from 40 to 1000 ns, pulses can be filtered or not filtered, according to operating temperature and voltage.

Package pinouts and signal descriptions

Table 24. I/O weight¹ (continued)

Supply segment			Pad	144/100 LQFP				64 LQFP			
				Weight 5 V		Weight 3.3 V		Weight 5 V		Weight 3.3 V	
144 LQFP	100 LQFP	64 LQFP ²		SRC ³ = 0	SRC = 1	SRC = 0	SRC = 1	SRC = 0	SRC = 1	SRC = 0	SRC = 1
3	3	2	PA[5]	5%	7%	6%	6%	6%	8%	7%	7%
			PA[6]	5%	—	6%	—	5%	—	6%	—
			PH[10]	4%	6%	5%	5%	5%	7%	6%	6%
			PC[1]	5%	—	5%	—	5%	—	5%	—
4	4	3	PC[0]	6%	9%	7%	8%	6%	9%	7%	8%
			PH[9]	7	7	8	8	7	7	8	8
			— PE[2]	7%	10%	9%	9%	—	—	—	—
		3	— PE[3]	8%	11%	9%	9%	—	—	—	—
			PC[5]	8%	11%	9%	10%	8%	11%	9%	10%
		3	PC[4]	8%	12%	10%	10%	8%	12%	10%	10%
			— PE[4]	8%	12%	10%	11%	—	—	—	—
		—	— PE[5]	9%	12%	10%	11%	—	—	—	—
			— PH[4]	9%	13%	11%	11%	—	—	—	—
		—	— PH[5]	9%	—	11%	—	—	—	—	—
			— PH[6]	9%	13%	11%	12%	—	—	—	—
		—	— PH[7]	9%	13%	11%	12%	—	—	—	—
			— PH[8]	10%	14%	11%	12%	—	—	—	—
		4	— PE[6]	10%	14%	12%	12%	—	—	—	—
			— PE[7]	10%	14%	12%	12%	—	—	—	—
			— PC[12]	10%	14%	12%	13%	—	—	—	—
			— PC[13]	10%	—	12%	—	—	—	—	—
			3 PC[8]	10%	—	12%	—	10%	—	12%	—
			PB[2]	10%	15%	12%	13%	10%	15%	12%	13%

¹ $V_{DD} = 3.3 \text{ V} \pm 10\% / 5.0 \text{ V} \pm 10\%$, $T_A = -40 \text{ to } 125^\circ\text{C}$, unless otherwise specified

² Segments shown apply to MPC560xB devices only

³ SRC: "Slew Rate Control" bit in SIU_PCR

3.16 RESET electrical characteristics

The device implements a dedicated bidirectional RESET pin.

Package pinouts and signal descriptions

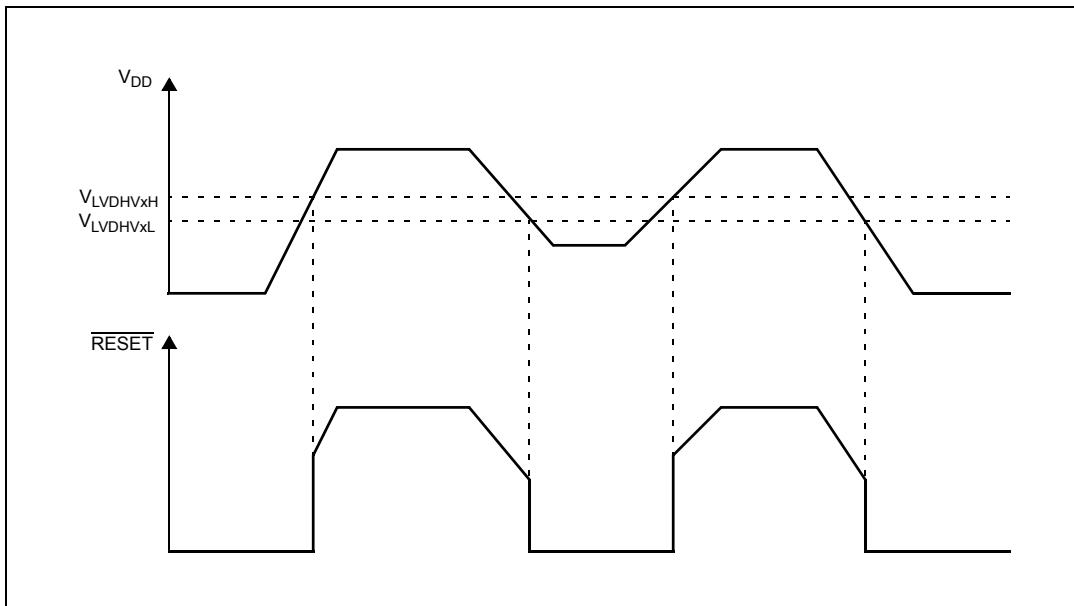


Figure 13. Low voltage detector vs reset

Table 27. Low voltage detector electrical characteristics

Symbol	C	Parameter	Conditions ¹	Value			Unit
				Min	Typ	Max	
V _{PORUP}	SR	P Supply for functional POR module	—	1.0	—	5.5	V
V _{PORH}	CC	Power-on reset threshold	T _A = 25 °C, after trimming	1.5	—	2.6	
			—	1.5	—	2.6	
V _{LVDHV3H}	CC	T LVDHV3 low voltage detector high threshold	—	—	—	2.95	
V _{LVDHV3L}	CC	P LVDHV3 low voltage detector low threshold		2.6	—	2.9	
V _{LVDHV5H}	CC	T LVDHV5 low voltage detector high threshold		—	—	4.5	
V _{LVDHV5L}	CC	P LVDHV5 low voltage detector low threshold		3.8	—	4.4	
V _{LVDLVCORL}	CC	P LVDLVCOR low voltage detector low threshold		1.08	—	1.16	
V _{LVDLVBKPL}	CC	P LVDLVBKP low voltage detector low threshold		1.08	—	1.16	

¹ V_{DD} = 3.3 V ± 10% / 5.0 V ± 10%, T_A = –40 to 125 °C, unless otherwise specified

3.18 Power consumption

Table 28 provides DC electrical characteristics for significant application modes. These values are indicative values; actual consumption depends on the application.

Package pinouts and signal descriptions

- ⁶ Data Flash Power Down. Code Flash in Low Power. SIRC (128 kHz) and FIRC (16 MHz) on. 10 MHz XTAL clock. FlexCAN: instances: 0, 1, 2 ON (clocked but not reception or transmission), instances: 4, 5, 6 clock gated. LINFlex: instances: 0, 1, 2 ON (clocked but not reception or transmission), instance: 3 clock gated. eMIOS: instance: 0 ON (16 channels on PA[0]–PA[11] and PC[12]–PC[15]) with PWM 20 kHz, instance: 1 clock gated. DSPI: instance: 0 (clocked but no communication). RTC/API ON. PIT ON. STM ON. ADC ON but not conversion except 2 analog watchdog.
- ⁷ Only for the “P” classification: No clock, FIRC (16 MHz) off, SIRC (128 kHz) on, PLL off, HPvreg off, ULPVreg/LPVreg on. All possible peripherals off and clock gated. Flash in power down mode.
- ⁸ When going from RUN to STOP mode and the core consumption is > 6 mA, it is normal operation for the main regulator module to be kept on by the on-chip current monitoring circuit. This is most likely to occur with junction temperatures exceeding 125 °C and under these circumstances, it is possible for the current to initially exceed the maximum STOP specification by up to 2 mA. After entering stop, the application junction temperature will reduce to the ambient level and the main regulator will be automatically switched off when the load current is below 6 mA.
- ⁹ Only for the “P” classification: ULPreg on, HP/LPVreg off, 32 KB RAM on, device configured for minimum consumption, all possible modules switched off.
- ¹⁰ ULPreg on, HP/LPVreg off, 8 KB RAM on, device configured for minimum consumption, all possible modules switched off.

3.19 Flash memory electrical characteristics

3.19.1 Program/Erase characteristics

Table 29 shows the program and erase characteristics.

Table 29. Program and erase specifications

Symbol	C	Parameter	Value				Unit
			Min	Typ ¹	Initial max ²	Max ³	
T _{dwprogram}	CC	Double word (64 bits) program time ⁴	—	22	50	500	μs
T _{16Kpperase}		16 KB block preprogram and erase time	—	300	500	5000	ms
T _{32Kpperase}		32 KB block preprogram and erase time	—	400	600	5000	ms
T _{128Kpperase}		128 KB block preprogram and erase time	—	800	1300	7500	ms
T _{esus}	CC	Erase suspend latency	—	—	30	30	μs

¹ Typical program and erase times assume nominal supply values and operation at 25 °C.

² Initial factory condition: < 100 program/erase cycles, 25 °C, typical supply voltage.

³ The maximum program and erase times occur after the specified number of program/erase cycles. These maximum values are characterized but not guaranteed.

⁴ Actual hardware programming times. This does not include software overhead.

Table 30. Flash module life

Symbol	C	Parameter	Conditions	Value			Unit
				Min	Typ	Max	
P/E	CC	Number of program/erase cycles per block over the operating temperature range (T_J)	16 KB blocks	100,000	—	—	cycles
			32 KB blocks	10,000	100,000	—	
			128 KB blocks	1,000	100,000	—	
Retention	CC	Minimum data retention at 85 °C average ambient temperature ¹	Blocks with 0–1,000 P/E cycles	20	—	—	years
			Blocks with 1,001–10,000 P/E cycles	10	—	—	
			Blocks with 10,001–100,000 P/E cycles	5	—	—	

¹ Ambient temperature averaged over duration of application, not to exceed recommended product operating temperature range.

ECC circuitry provides correction of single bit faults and is used to improve further automotive reliability results. Some units will experience single bit corrections throughout the life of the product with no impact to product reliability.

Table 31. Flash read access timing

Symbol	C	Parameter	Conditions ¹	Max	Unit
f _{READ}	CC	Maximum frequency for Flash reading	2 wait states	64	MHz
			1 wait state	40	
			0 wait states	20	

¹ V_{DD} = 3.3 V ± 10% / 5.0 V ± 10%, T_A = –40 to 125 °C, unless otherwise specified

3.19.2 Flash power supply DC characteristics

Table 32 shows the power supply DC characteristics on external supply.

Table 32. Flash memory power supply DC electrical characteristics

Symbol	C	Parameter	Conditions ¹	Value			Unit
				Min	Typ	Max	
I _{FREAD} ²	CC	Sum of the current consumption on VDD_HV and VDD_BV on read access	Code flash memory module read f _{CPU} = 64 MHz ³	—	15	33	mA
			Data flash memory module read f _{CPU} = 64 MHz ³	—	15	33	
I _{FMOD} ²	CC	Sum of the current consumption on VDD_HV and VDD_BV on matrix modification (program/erase)	Program/Erase ongoing while reading code flash memory registers f _{CPU} = 64 MHz ³	—	15	33	mA
			Program/Erase ongoing while reading data flash memory registers f _{CPU} = 64 MHz ³	—	15	33	

Table 41. FMPLL electrical characteristics

Symbol	C	Parameter	Conditions ¹	Value			Unit
				Min	Typ	Max	
f _{PLLIN}	SR	FMPLL reference clock ²	—	4	—	64	MHz
Δ _{PLLIN}	SR	FMPLL reference clock duty cycle ²	—	40	—	60	%
f _{PLLOUT}	CC	D	FMPLL output clock frequency	—	16	—	64 MHz
f _{VCO} ³	CC	P	VCO frequency without frequency modulation	—	256	—	512 MHz
		C	VCO frequency with frequency modulation	—	245	—	533
f _{CPU}	SR	—	System clock frequency	—	—	64	MHz
f _{FREE}	CC	P	Free-running frequency	—	20	—	150 MHz
t _{LOCK}	CC	P	FMPLL lock time	Stable oscillator (f _{PLLIN} = 16 MHz)	—	40	100 μs
Δt _{STJIT}	CC	—	FMPLL short term jitter ⁴	f _{sys} maximum	-4	—	4 %
Δt _{LTJIT}	CC	—	FMPLL long term jitter	f _{PLLIN} = 16 MHz (resonator), f _{PLLCLK} @ 64 MHz, 4000 cycles	—	—	10 ns
I _{PLL}	CC	C	FMPLL consumption	T _A = 25 °C	—	—	4 mA

¹ V_{DD} = 3.3 V ± 10% / 5.0 V ± 10%, T_A = -40 to 125 °C, unless otherwise specified.

² PLLIN clock retrieved directly from FXOSC clock. Input characteristics are granted when oscillator is used in functional mode. When bypass mode is used, oscillator input clock should verify f_{PLLIN} and Δ_{PLLIN}.

³ Frequency modulation is considered ±4%

⁴ Short term jitter is measured on the clock rising edge at cycle n and n+4.

3.24 Fast internal RC oscillator (16 MHz) electrical characteristics

The device provides a 16 MHz fast internal RC oscillator. This is used as the default clock at the power-up of the device.

Table 42. Fast internal RC oscillator (16 MHz) electrical characteristics

Symbol	C	Parameter	Conditions ¹	Value			Unit
				Min	Typ	Max	
f _{FIRC}	CC	P	Fast internal RC oscillator high frequency	T _A = 25 °C, trimmed	—	16	MHz
	SR	—		—	12	—	
I _{FIRCRUN} ²	CC	T	Fast internal RC oscillator high frequency current in running mode	T _A = 25 °C, trimmed	—	—	200 μA
I _{FIRCPWD}	CC	D	Fast internal RC oscillator high frequency current in power down mode	T _A = 125 °C	—	—	10 μA

3.26 ADC electrical characteristics

3.26.1 Introduction

The device provides a 10-bit Successive Approximation Register (SAR) analog-to-digital converter.

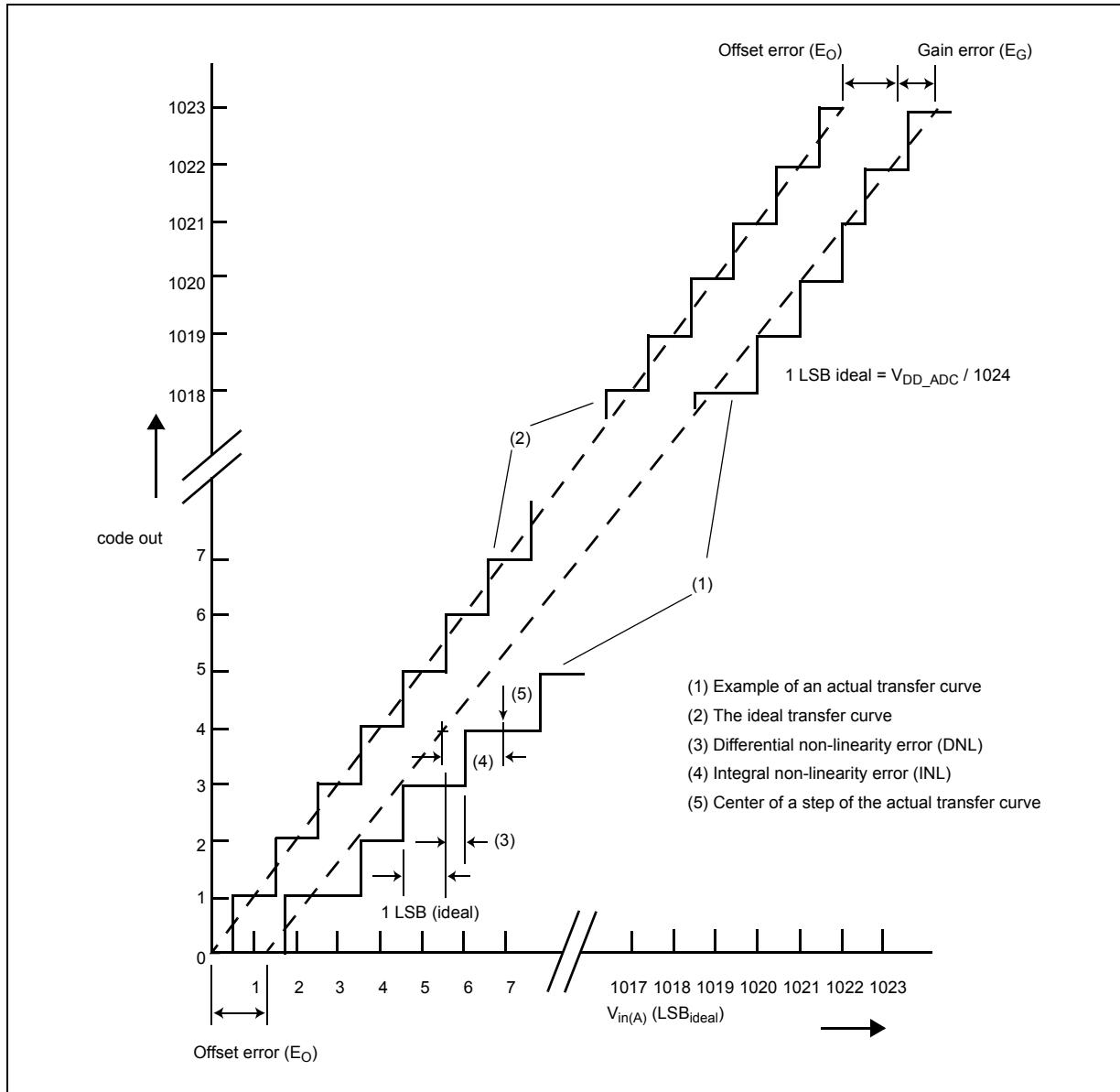
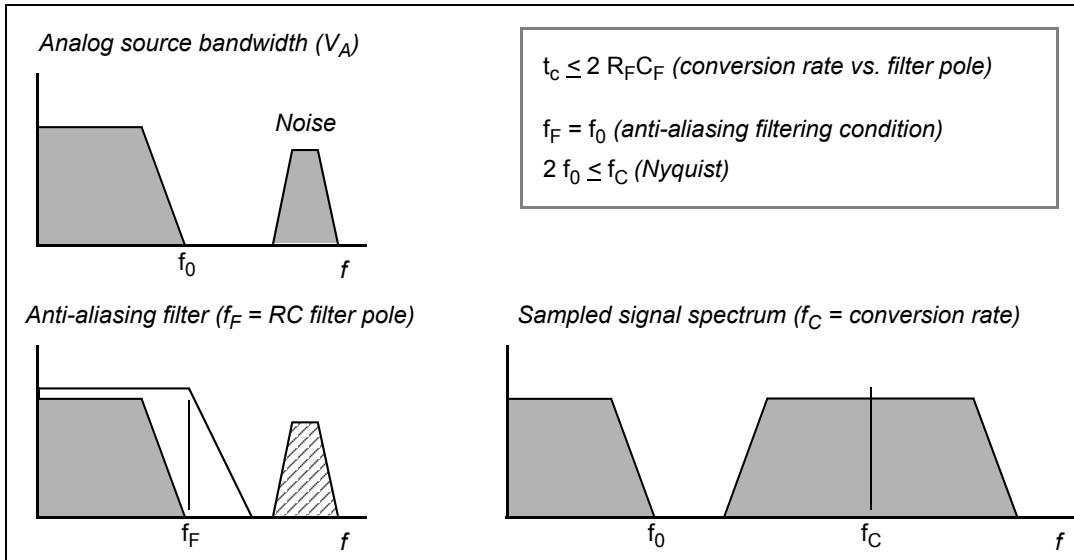


Figure 19. ADC characteristic and error definitions

3.26.2 Input impedance and ADC accuracy

In the following analysis, the input circuit corresponding to the precise channels is considered.

To preserve the accuracy of the A/D converter, it is necessary that analog input pins have low AC impedance. Placing a capacitor with good high frequency characteristics at the input pin of the device can be effective: the capacitor should be as large as

**Figure 23. Spectral representation of input signal**

Calling f_0 the bandwidth of the source signal (and as a consequence the cut-off frequency of the anti-aliasing filter, f_F), according to the Nyquist theorem the conversion rate f_C must be at least $2f_0$; it means that the constant time of the filter is greater than or at least equal to twice the conversion period (t_c). Again the conversion period t_c is longer than the sampling time t_s , which is just a portion of it, even when fixed channel continuous conversion mode is selected (fastest conversion rate at a specific channel): in conclusion it is evident that the time constant of the filter $R_F C_F$ is definitively much higher than the sampling time t_s , so the charge level on C_S cannot be modified by the analog signal source during the time in which the sampling switch is closed.

The considerations above lead to impose new constraints on the external circuit, to reduce the accuracy error due to the voltage drop on C_S ; from the two charge balance equations above, it is simple to derive [Equation 11](#) between the ideal and real sampled voltage on C_S :

Eqn. 11

$$\frac{V_{A2}}{V_A} = \frac{C_{P1} + C_{P2} + C_F}{C_{P1} + C_{P2} + C_F + C_S}$$

From this formula, in the worst case (when V_A is maximum, that is for instance 5 V), assuming to accept a maximum error of half a count, a constraint is evident on C_F value:

Eqn. 12

$$C_F > 2048 \cdot C_S$$

3.26.3 ADC electrical characteristics

Table 44. ADC input leakage current

Symbol	C	Parameter	Conditions	Value			Unit	
				Min	Typ	Max		
I_{LKG}	CC	Input leakage current	$T_A = -40^\circ C$ $T_A = 25^\circ C$ $T_A = 85^\circ C$ $T_A = 105^\circ C$ $T_A = 125^\circ C$	No current injection on adjacent pin	—	1	70	nA
					—	1	70	
					—	3	100	
					—	8	200	
					—	45	400	

Table 45. ADC conversion characteristics

Symbol	C	Parameter	Conditions ¹	Value			Unit
				Min	Typ	Max	
V_{SS_ADC}	SR	—	Voltage on $V_{SS_HV_ADC}$ (ADC reference) pin with respect to ground (V_{ss}) ²	—	—0.1	—	0.1 V
V_{DD_ADC}	SR	—	Voltage on $V_{DD_HV_ADC}$ pin (ADC reference) with respect to ground (V_{ss})	—	$V_{DD} - 0.1$	—	$V_{DD} + 0.1$ V
V_{AINx}	SR	—	Analog input voltage ³	—	$V_{SS_ADC} - 0.1$	—	$V_{DD_ADC} + 0.1$ V
f_{ADC}	SR	—	ADC analog frequency	—	6	—	32 + 4% MHz
Δ_{ADC_SYS}	SR	—	ADC digital clock duty cycle (ipg_clk)	$ADCLKSEL = 1^4$	45	—	55 %
I_{ADCPWD}	SR	—	ADC0 consumption in power down mode	—	—	—	50 μA
I_{ADCRUN}	SR	—	ADC0 consumption in running mode	—	—	—	4 mA
t_{ADC_PU}	SR	—	ADC power up delay	—	—	—	1.5 μs
t_s	CC	T	Sampling time ⁵	$f_{ADC} = 32$ MHz, INPSAMP = 17	0.5	—	μs
				$f_{ADC} = 6$ MHz, INPSAMP = 255	—	—	
t_c	CC	P	Conversion time ⁶	$f_{ADC} = 32$ MHz, INPCMP = 2	0.625	—	μs
C_S	CC	D	ADC input sampling capacitance	—	—	—	3 pF
C_{P1}	CC	D	ADC input pin capacitance 1	—	—	—	3 pF
C_{P2}	CC	D	ADC input pin capacitance 2	—	—	—	1 pF

Package pinouts and signal descriptions

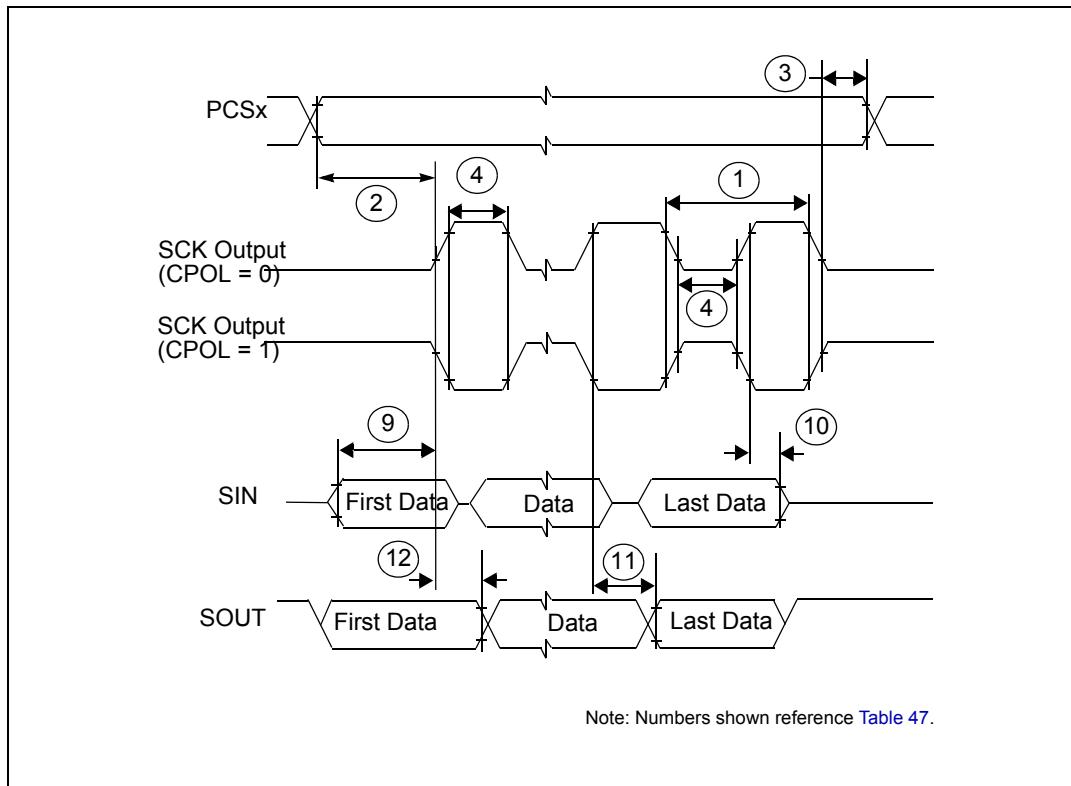


Figure 28. DSPI modified transfer format timing – master, CPHA = 0

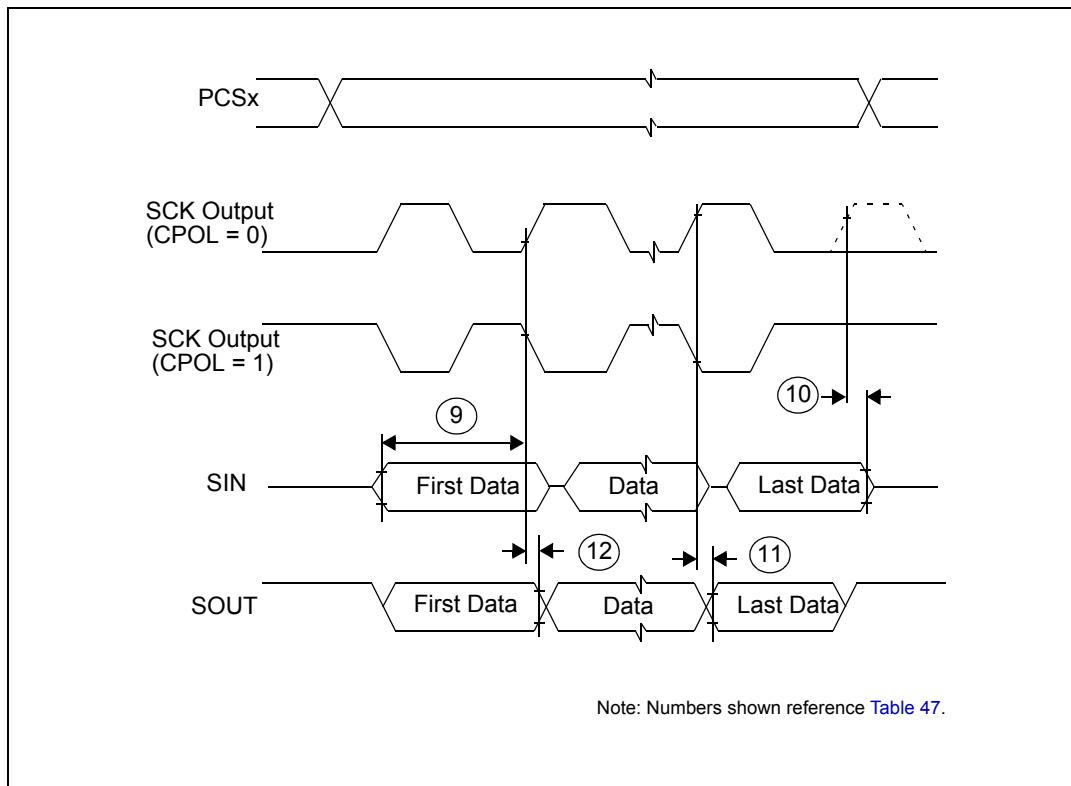


Figure 29. DSPI modified transfer format timing – master, CPHA = 1

Package pinouts and signal descriptions

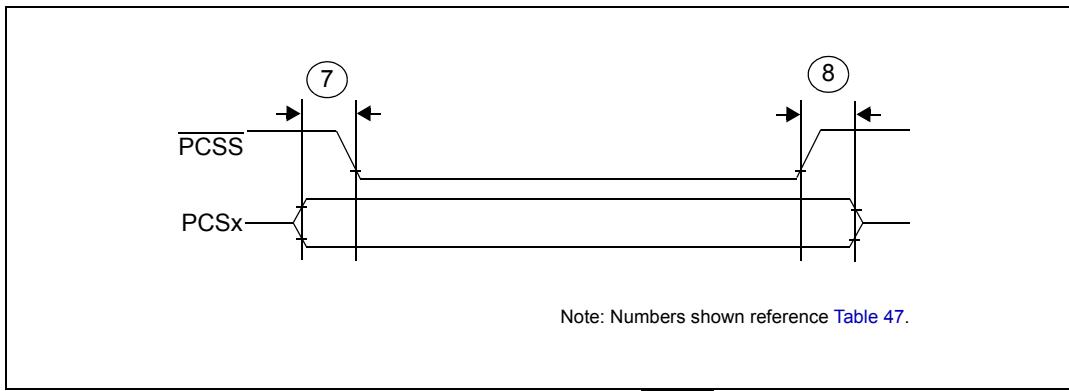


Figure 32. DSPI PCS strobe (PCSS) timing

3.27.3 Nexus characteristics

Table 48. Nexus characteristics

No.	Symbol	C	Parameter	Value			Unit
				Min	Typ	Max	
1	t_{TCYC}	CC	D TCK cycle time	64	—	—	ns
2	t_{MCYC}	CC	D MCKO cycle time	32	—	—	ns
3	t_{MDOV}	CC	D MCKO low to MDO data valid	—	—	8	ns
4	t_{MSEOV}	CC	D MCKO low to MSEO_b data valid	—	—	8	ns
5	t_{EVTOV}	CC	D MCKO low to EVTO data valid	—	—	8	ns
10	t_{NTDIS}	CC	D TDI data setup time	15	—	—	ns
	t_{NTMSS}	CC	D TMS data setup time	15	—	—	ns
11	t_{NTDIH}	CC	D TDI data hold time	5	—	—	ns
	t_{NTMSH}	CC	D TMS data hold time	5	—	—	ns
12	t_{TDOV}	CC	D TCK low to TDO data valid	35	—	—	ns
13	t_{TDOI}	CC	D TCK low to TDO data invalid	6	—	—	ns

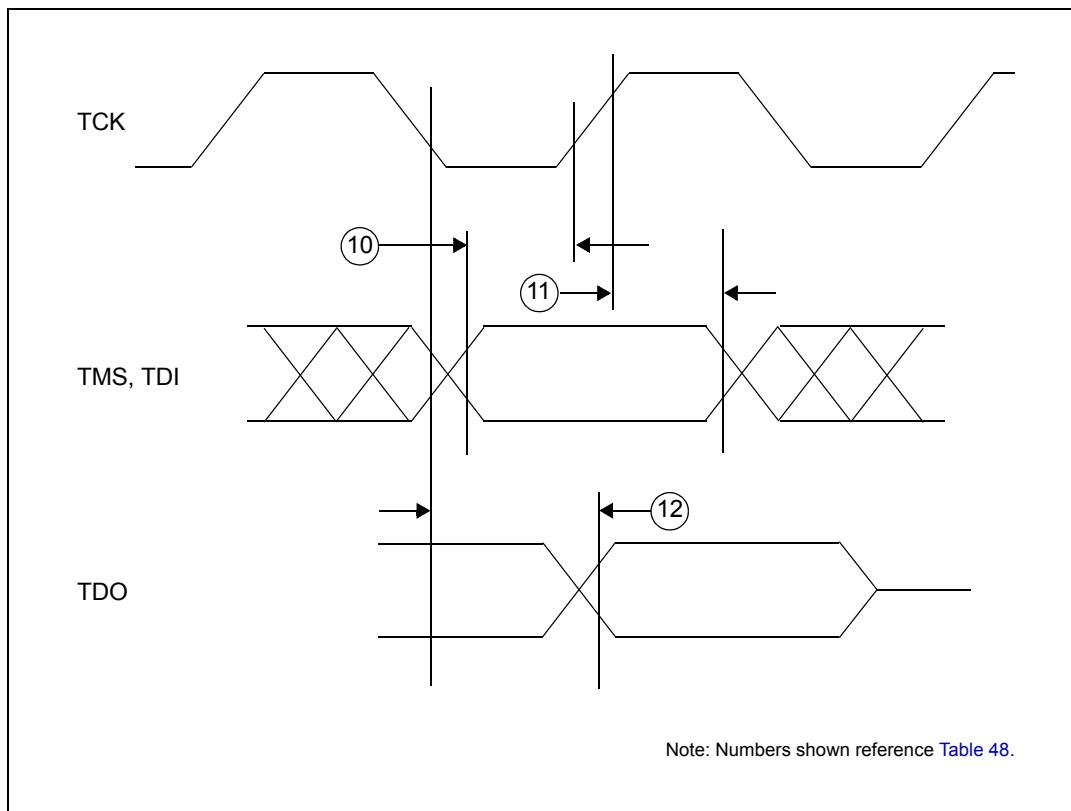


Figure 33. Nexus TDI, TMS, TDO timing

3.27.4 JTAG characteristics

Table 49. JTAG characteristics

No.	Symbol	C	Parameter	Value			Unit
				Min	Typ	Max	
1	t_{JCYC}	CC	TCK cycle time	64	—	—	ns
2	t_{TDIS}	CC	TDI setup time	15	—	—	ns
3	t_{TDIH}	CC	TDI hold time	5	—	—	ns
4	t_{TMSS}	CC	TMS setup time	15	—	—	ns
5	t_{TMSH}	CC	TMS hold time	5	—	—	ns
6	t_{TDOV}	CC	TCK low to TDO valid	—	—	33	ns
7	t_{TDOI}	CC	TCK low to TDO invalid	6	—	—	ns

Package characteristics

 <p>© FREESCALE SEMICONDUCTOR. ALL RIGHTS RESERVED. ELECTRONIC VERSIONS ARE UNCONTROLLED, EXCEPT WHEN ACCESSED DIRECTLY FROM THE DOCUMENT CONTROL REPOSITORY. PRINTED VERSIONS ARE UNCONTROLLED EXCEPT WHEN STAMPED "CONTROLLED COPY" IN RED.</p>	MECHANICAL OUTLINES DICTIONARY	DOCUMENT NO: 98ASS23308W
		PAGE: 983
	DO NOT SCALE THIS DRAWING	REV: H
NOTES:		
<p>1. ALL DIMENSIONS ARE IN MILLIMETERS.</p> <p>2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.</p> <p>3. DATUMS B, C AND D TO BE DETERMINED AT DATUM PLANE H.</p> <p>4. THE TOP PACKAGE BODY SIZE MAY BE SMALLER THAN THE BOTTOM PACKAGE SIZE BY A MAXIMUM OF 0.1 MM.</p> <p>5. DIMENSIONS DO NOT INCLUDE MOLD PROTRUSIONS. THE MAXIMUM ALLOWABLE PROTRUSION IS 0.25 mm PER SIDE. THE DIMENSIONS ARE MAXIMUM BODY SIZE DIMENSIONS INCLUDING MOLD MISMATCH.</p> <p>6. DIMENSION DOES NOT INCLUDE DAM BAR PROTRUSION. PROTRUSIONS SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED 0.35. MINIMUM SPACE BETWEEN PROTRUSION AND AN ADJACENT LEAD SHALL BE 0.07 MM.</p> <p>7. DIMENSIONS ARE DETERMINED AT THE SEATING PLANE, DATUM A.</p>		
TITLE: 100 LEAD LQFP 14 X 14, 0.5 PITCH, 1.4 THICK	CASE NUMBER: 983-02	
	STANDARD: NON-JEDEC	
	PACKAGE CODE: 8264	SHEET: 3

Figure 40. 100 LQFP package mechanical drawing (3 of 3)

Package characteristics

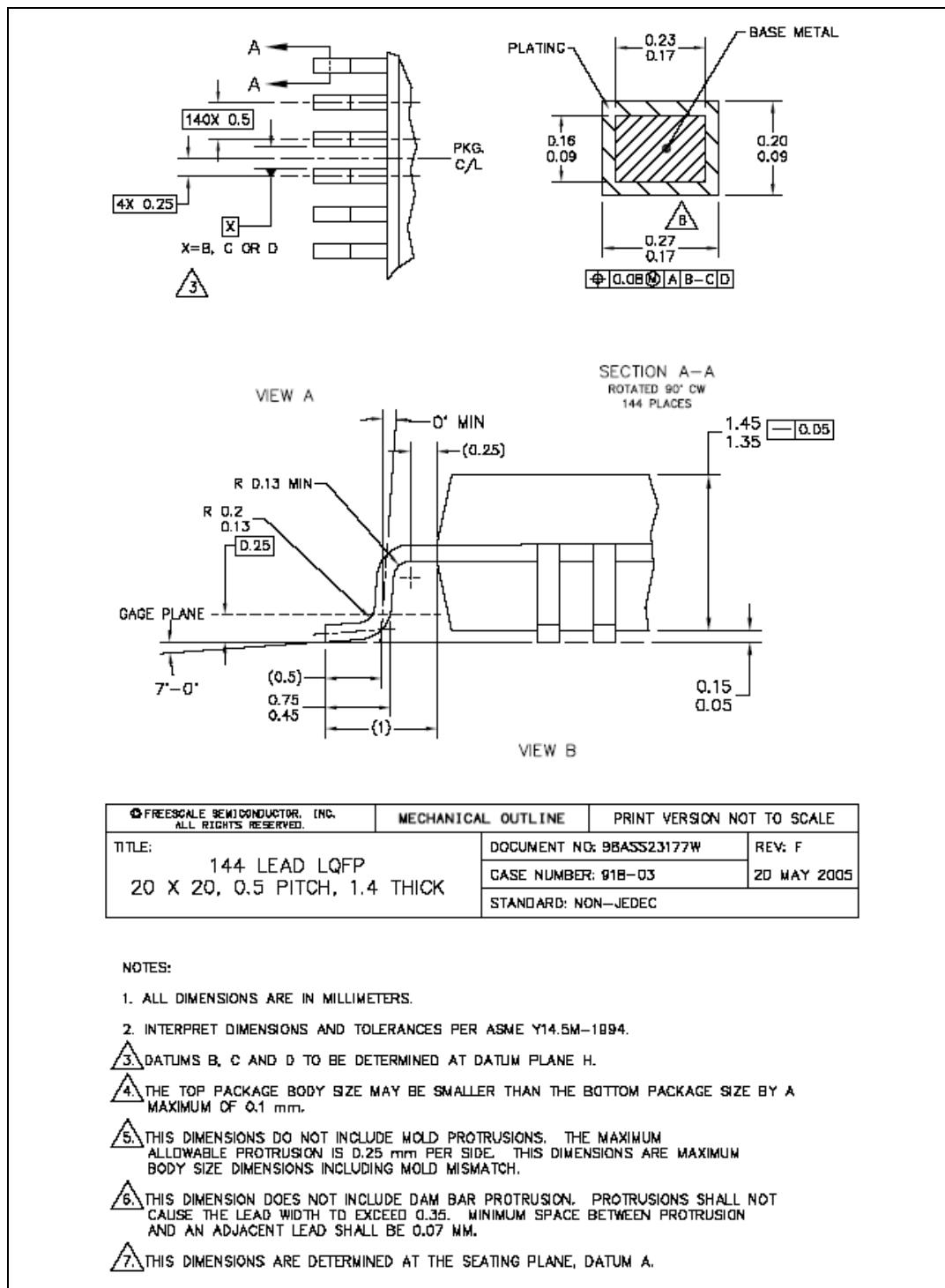
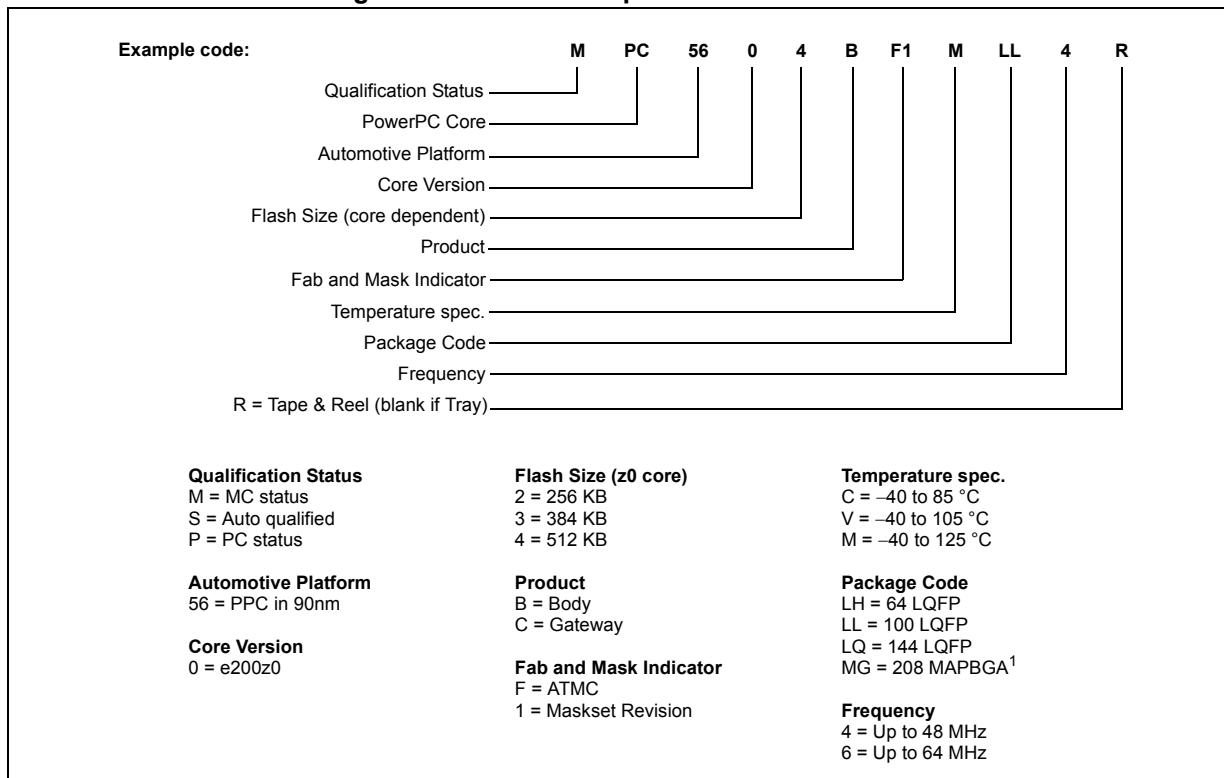


Figure 42. 144 LQFP package mechanical drawing (2 of 2)

5 Ordering information

Figure 45. Commercial product code structure



¹ 208 MAPBGA available only as development package for Nexus2+

6 Document revision history

Table 50 summarizes revisions to this document.

Table 50. Revision history

Revision	Date	Description of Changes
1	04-Apr-2008	Initial release.